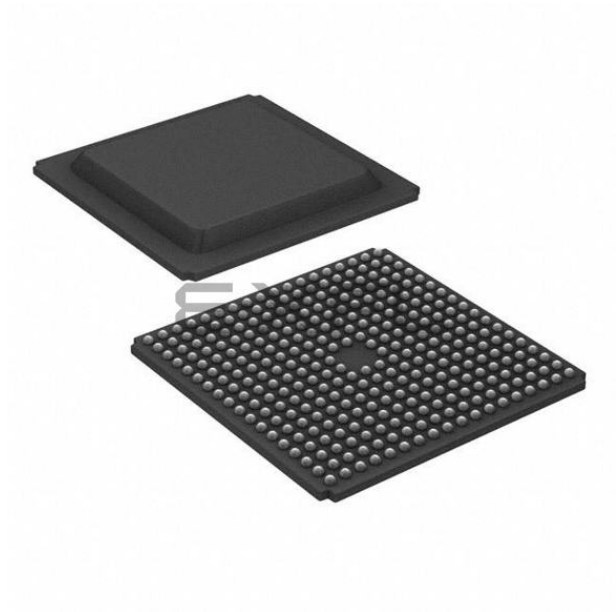

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Understanding Embedded - FPGAs (Field Programmable Gate Array)

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details	
Product Status	Active
Number of LABs/CLBs	896
Number of Logic Elements/Cells	8064
Total RAM Bits	294912
Number of I/O	221
Number of Gates	400000
Voltage - Supply	1.14V ~ 1.26V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	320-BGA
Supplier Device Package	320-FBGA (19x19)
Purchase URL	https://www.e-xfl.com/product-detail/xilinx/xc3s400-5fg320c

ESD Protection

Clamp diodes protect all device pads against damage from Electro-Static Discharge (ESD) as well as excessive voltage transients. Each I/O has two clamp diodes: One diode extends P-to-N from the pad to V_{CCO} and a second diode extends N-to-P from the pad to GND. During operation, these diodes are normally biased in the off state. These clamp diodes are always connected to the pad, regardless of the signal standard selected. The presence of diodes limits the ability of Spartan-3 FPGA I/Os to tolerate high signal voltages. The V_{IN} absolute maximum rating in Table 28, page 58 specifies the voltage range that I/Os can tolerate.

Slew Rate Control and Drive Strength

Two options, FAST and SLOW, control the output slew rate. The FAST option supports output switching at a high rate. The SLOW option reduces bus transients. These options are only available when using one of the LVCMOS or LVTTL standards, which also provide up to seven different levels of current drive strength: 2, 4, 6, 8, 12, 16, and 24 mA. Choosing the appropriate drive strength level is yet another means to minimize bus transients.

Table 7 shows the drive strengths that the LVCMOS and LVTTL standards support.

Table 7: **Programmable Output Drive Current**

Signal Standard (IOSTANDARD)	Current Drive (mA)						
	2	4	6	8	12	16	24
LVTTL	✓	✓	✓	✓	✓	✓	✓
LVCMOS33	✓	✓	✓	✓	✓	✓	✓
LVCMOS25	✓	✓	✓	✓	✓	✓	✓
LVCMOS18	✓	✓	✓	✓	✓	✓	–
LVCMOS15	✓	✓	✓	✓	✓	–	–
LVCMOS12	✓	✓	✓	–	–	–	–

Boundary-Scan Capability

All Spartan-3 FPGA IOBs support boundary-scan testing compatible with IEEE 1149.1 standards. During boundary- scan operations such as EXTEST and HIGHZ the I/O pull-down resistor is active. For more information, see Boundary-Scan (JTAG) Mode, page 50, and refer to the “Using Boundary-Scan and BSDL Files” chapter in UG331.

SelectIO Interface Signal Standards

The IOBs support 18 different single-ended signal standards, as listed in Table 8. Furthermore, the majority of IOBs can be used in specific pairs supporting any of eight differential signal standards, as shown in Table 9.

To define the SelectIO™ interface signaling standard in a design, set the IOSTANDARD attribute to the appropriate setting. Xilinx provides a variety of different methods for applying the IOSTANDARD for maximum flexibility. For a full description of different methods of applying attributes to control IOSTANDARD, refer to the “Using I/O Resources” chapter in UG331.

Together with placing the appropriate I/O symbol, two externally applied voltage levels, V_{CCO} and V_{REF}, select the desired signal standard. The V_{CCO} lines provide current to the output driver. The voltage on these lines determines the output voltage swing for all standards except GTL and GTLP.

All single-ended standards except the LVCMOS, LVTTL, and PCI varieties require a Reference Voltage (V_{REF}) to bias the input-switching threshold. Once a configuration data file is loaded into the FPGA that calls for the I/Os of a given bank to use such a signal standard, a few specifically reserved I/O pins on the same bank automatically convert to V_{REF} inputs. When using one of the LVCMOS standards, these pins remain I/Os because the V_{CCO} voltage biases the input-switching threshold, so there is no need for V_{REF}. Select the V_{CCO} and V_{REF} levels to suit the desired single-ended standard according to Table 8.

The product of w and n yields the total block RAM capacity. Equation 1 and Equation 2 show that as the data bus width increases, the number of address lines along with the number of addressable memory locations decreases. Using the permissible DI/DO bus widths as inputs to these equations provides the bus width and memory capacity measures shown in Table 14.

Table 14: **Port Aspect Ratios for Port A or B**

DI/DO Bus Width (w – p Bits)	DIP/DOP Bus Width (p Bits)	Total Data Path Width (w Bits)	ADDR Bus Width (r Bits)	No. of Addressable Locations (n)	Block RAM Capacity (Bits)
1	0	1	14	16,384	16,384
2	0	2	13	8,192	16,384
4	0	4	12	4,096	16,384
8	1	9	11	2,048	18,432
16	2	18	10	1,024	18,432
32	4	36	9	512	18,432

Block RAM Data Operations

Writing data to and accessing data from the block RAM are synchronous operations that take place independently on each of the two ports.

The waveforms for the write operation are shown in the top half of the Figure 15, Figure 16, and Figure 17. When the WE and EN signals enable the active edge of CLK, data at the DI input bus is written to the block RAM location addressed by the ADDR lines.

There are a number of different conditions under which data can be accessed at the DO outputs. Basic data access always occurs when the WE input is inactive. Under this condition, data stored in the memory location addressed by the ADDR lines passes through a transparent output latch to the DO outputs. The timing for basic data access is shown in the portions of Figure 15, Figure 16, and Figure 17 during which WE is Low.

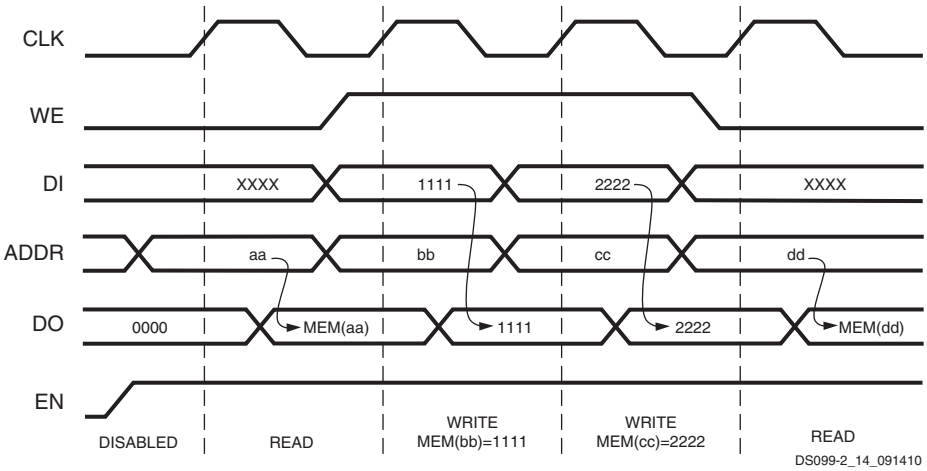


Figure 15: **Waveforms of Block RAM Data Operations with WRITE_FIRST Selected**

Data can also be accessed on the DO outputs when asserting the WE input. This is accomplished using two different attributes:

Choosing the WRITE_FIRST attribute, data is written to the addressed memory location on an enabled active CLK edge and is also passed to the DO outputs. WRITE_FIRST timing is shown in the portion of Figure 15 during which WE is High.

Choosing the READ_FIRST attribute, data already stored in the addressed location pass to the DO outputs before that location is overwritten with new data from the DI inputs on an enabled active CLK edge. READ_FIRST timing is shown in the portion of Figure 16 during which WE is High.

DFS Clock Output Connections

There are two basic cases that determine how to connect the DFS clock outputs: on-chip and off-chip, which are illustrated in sections [a] and [c], respectively, of Figure 21. This is similar to what has already been described for the DLL component. See DLL Clock Output and Feedback Connections, page 34.

In the on-chip case, it is possible to connect either of the DFS's two output clock signals through general routing resources to the FPGA's internal registers. Either a Global Clock Buffer (BUFG) or a BUFGMUX affords access to the global clock network. The optional feedback loop is formed in this way, routing CLK0 to a global clock net, which in turn drives the CLKFB input.

In the off-chip case, the DFS's two output clock signals, plus CLK0 for an optional feedback loop, can exit the FPGA using output buffers (OBUF) to drive a clock network plus registers on the board. The feedback loop is formed by feeding the CLK0 signal back into the FPGA using an IBUFG, which directly accesses the global clock network, or an IBUF. Then, the global clock net is connected directly to the CLKFB input.

Phase Shifter (PS)

The DCM provides two approaches to controlling the phase of a DCM clock output signal relative to the CLKIN signal: First, there are nine clock outputs that employ the DLL to achieve a desired phase relationship: CLK0, CLK90, CLK180, CLK270, CLK2X, CLK2X180, CLKDV CLKFX, and CLKFX180. These outputs afford "coarse" phase control.

The second approach uses the PS component described in this section to provide a still finer degree of control. The PS component is only available when the DLL is operating in its low-frequency mode. The PS component phase shifts the DCM output clocks by introducing a "fine phase shift" (T_{PS}) between the CLKFB and CLKIN signals inside the DLL component. The user can control this fine phase shift down to a resolution of 1/256 of a CLKIN cycle or one tap delay (DCM_TAP), whichever is greater. When in use, the PS component shifts the phase of all nine DCM clock output signals together. If the PS component is used together with a DCM clock output such as the CLK90, CLK180, CLK270, CLK2X180 and CLKFX180, then the fine phase shift of the former gets added to the coarse phase shift of the latter.

PS Component Enabling and Mode Selection

The CLKOUT_PHASE_SHIFT attribute enables the PS component for use in addition to selecting between two operating modes. As described in Table 20, this attribute has three possible values: NONE, FIXED and VARIABLE. When CLKOUT_PHASE_SHIFT is set to NONE, the PS component is disabled and its inputs, PSEN, PSCLK, and PSINCDEC, must be tied to GND. The set of waveforms in section [a] of Figure 22 shows the disabled case, where the DLL maintains a zero-phase alignment of signals CLKFB and CLKIN upon which the PS component has no effect. The PS component is enabled by setting the attribute to either the FIXED or VARIABLE values, which select the Fixed Phase mode and the Variable Phase mode, respectively. These two modes are described in the sections that follow

Determining the Fine Phase Shift

The user controls the phase shift of CLKFB relative to CLKIN by setting and/or adjusting the value of the PHASE_SHIFT attribute. This value must be an integer ranging from –255 to +255. The PS component uses this value to calculate the desired fine phase shift (T_{PS}) as a fraction of the CLKIN period (T_{CLKIN}). Given values for PHASE-SHIFT and T_{CLKIN}, it is possible to calculate T_{PS} as follows:

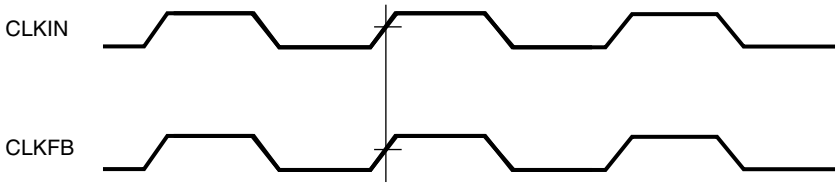
$$T_{PS} = T_{CLKIN}(PHASE\_SHIFT/256) \qquad \textit{Equation 4}$$

Both the Fixed Phase and Variable Phase operating modes employ this calculation. If the PHASE_SHIFT value is zero, then CLKFB and CLKIN will be in phase, the same as when the PS component is disabled. When the PHASE_SHIFT value is positive, the CLKFB signal will be shifted later in time with respect to CLKIN. If the attribute value is negative, the CLKFB signal will be shifted earlier in time with respect to CLKIN.

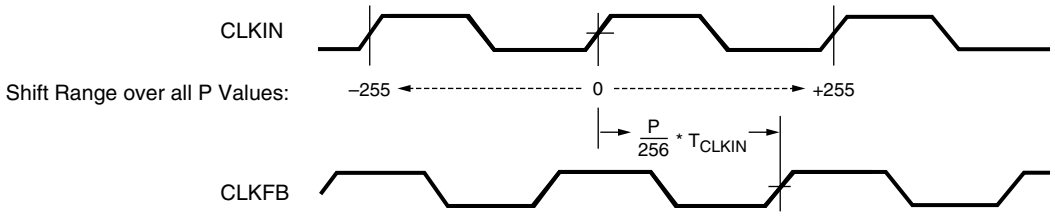
The Fixed Phase Mode

This mode fixes the desired fine phase shift to a fraction of the T_{CLKIN}, as determined by Equation 4 and its user-selected PHASE_SHIFT value P. The set of waveforms insection [b] of Figure 22 illustrates the relationship between CLKFB and CLKIN in the Fixed Phase mode. In the Fixed Phase mode, the PSEN, PSCLK and PSINCDEC inputs are not used and must be tied to GND. Fixed phase shift requires ISE software version 10.1.03 or later.

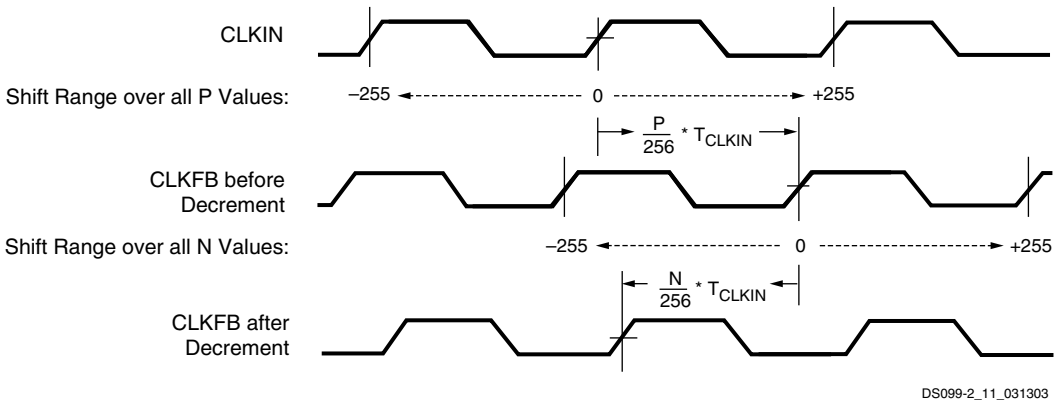
a. CLKOUT_PHASE_SHIFT = NONE



b. CLKOUT_PHASE_SHIFT = FIXED



c. CLKOUT_PHASE_SHIFT = VARIABLE



Notes:

1. P represents the integer value ranging from –255 to +255 to which the PHASE_SHIFT attribute is assigned.
2. N is an integer value ranging from –255 to +255 that represents the net phase shift effect from a series of increment and/or decrement operations.
   N = {Total number of increments} – {Total number of decrements}
   A positive value for N indicates a net increment; a negative value indicates a net decrement.

Figure 23: **Phase Shifter Waveforms**

The Status Logic Component

The Status Logic component not only reports on the state of the DCM but also provides a means of resetting the DCM to an initial known state. The signals associated with the Status Logic component are described in Table 22.

As a rule, the Reset (RST) input is asserted only upon configuring the device or changing the CLKIN frequency. A DCM reset does not affect attribute values (e.g., CLKFX_MULTIPLY and CLKFX_DIVIDE). If not used, RST must be tied to GND.

The eight bits of the STATUS bus are defined in Table 23.

The Standard Configuration Interface

Configuration signals belong to one of two different categories: Dedicated or Dual-Purpose. Which category determines which of the FPGA's power rails supplies the signal's driver and, thus, helps describe the electrical characteristics at the pin.

The Dedicated configuration pins include PROG_B, HSWAP_EN, TDI, TMS, TCK, TDO, CCLK, DONE, and M0-M2. These pins are powered by the V_{CCAUX} supply.

The Dual-Purpose configuration pins comprise INIT_B, DOUT, BUSY, RDWR_B, CS_B, and DIN/D0-D7. Each of these pins, according to its bank placement, uses the V_{CCO} lines for either Bank 4 (VCCO_4 on most packages, VCCO_BOTTOM on TQ144 and CP132 packages) or Bank 5 (VCCO_5). All the signals used in the serial configuration modes rely on VCCO_4 power. Signals used in the parallel configuration modes and Readback require from VCCO_5 as well as from VCCO_4.

Both the Dedicated signals described above and the Dual-Purpose signals constitute the configuration interface. The Dedicated pins, powered by the 2.5V V_{CCAUX} supply, always use the LVCMOS25 I/O standard. The Dual-Purpose signals, however, are powered by the VCCO_4 supply and also by the VCCO_5 supply in the Parallel configuration modes. The simplest configuration interface uses 2.5V for VCCO_4 and VCCO_5, if required. However, VCCO_4 and, if needed, VCCO_5 can be voltages other than 2.5V but then the configuration interface will have two voltage levels: 2.5V for V_{CCAUX} and a separate V_{CCO} supply. The Dual-Purpose signals default to the LVCMOS input and output levels for the associated V_{CCO} voltage supply.

3.3V-Tolerant Configuration Interface

A 3.3V-tolerant configuration interface simply requires adding a few external resistors as described in detail in XAPP453: *The 3.3V Configuration of Spartan-3 FPGAs*.

The 3.3V-tolerance is implemented as follows (a similar approach can be used for other supply voltage levels):

Apply 3.3V to VCCO_4 and, in some configuration modes, to VCCO_5 to power the Dual-Purpose configuration pins. This scales the output voltages and input thresholds associated with these pins so that they become 3.3V-compatible.

Apply 2.5V to V_{CCAUX} to power the Dedicated configuration pins. For 3.3V-tolerance, the Dedicated inputs require series resistors to limit the incoming current to 10 mA or less. The Dedicated outputs have reduced noise margin when the FPGA drives a High logic level into another device's 3.3V receiver. Choose a power regulator or supply that can tolerate reverse current on the V_{CCAUX} lines.

Configuration Modes

Spartan-3 FPGAs support the following five configuration modes:

- Slave Serial mode
- Master Serial mode
- Slave Parallel (SelectMAP) mode
- Master Parallel (SelectMAP) mode
- Boundary-Scan (JTAG) mode (IEEE 1532/IEEE 1149.1)

Slave Serial Mode

In Slave Serial mode, the FPGA receives configuration data in bit-serial form from a serial PROM or other serial source of configuration data. The FPGA on the far right of Figure 26 is set for the Slave Serial mode. The CCLK pin on the FPGA is an input in this mode. The serial bitstream must be set up at the DIN input pin a short time before each rising edge of the externally generated CCLK.

Multiple FPGAs can be daisy-chained for configuration from a single source. After a particular FPGA has been configured, the data for the next device is routed internally to the DOUT pin. The data on the DOUT pin changes on the falling edge of CCLK.

Table 30: **Power Voltage Ramp Time Requirements**

Symbol	Description	Device	Package	Min	Max	Units
T_{CCO}	V_{CCO} ramp time for all eight banks	All	All	No limit(4)	–	N/A
T_{CCINT}	V_{CCINT} ramp time, only if V_{CCINT} is last in three-rail power-on sequence	All	All	No limit	No limit(5)	N/A

Notes:

1. If a limit exists, this specification is based on characterization.
2. The ramp time is measured from 10% to 90% of the full nominal voltage swing for all I/O standards.
3. For information on power-on current needs, see Power-On Behavior, page 54
4. For mask revisions earlier than revision E (see Mask and Fab Revisions, page 58), T_{CCO} min is limited to 2.0 ms for the XC3S200 and XC3S400 devices in QFP packages, and limited to 0.6 ms for the XC3S200, XC3S400, XC3S1500, and XC3S4000 devices in the FT and FG packages.
5. For earlier device versions with the FQ fabrication/process code (see Mask and Fab Revisions, page 58), T_{CCINT} max is limited to 500 µs.

Table 31: **Power Voltage Levels Necessary for Preserving RAM Contents**

Symbol	Description	Min	Units
V_{DRINT}	V_{CCINT} level required to retain RAM data	1.0	V
V_{DRAUX}	V_{CCAUX} level required to retain RAM data	2.0	V

Notes:

1. RAM contents include data stored in CMOS configuration latches.
2. The level of the V_{CCO} supply has no effect on data retention.
3. If a brown-out condition occurs where V_{CCAUX} or V_{CCINT} drops below the retention voltage, then V_{CCAUX} or V_{CCINT} must drop below the minimum power-on reset voltage indicated in Table 29 in order to clear out the device configuration content.

Table 32: **General Recommended Operating Conditions**

Symbol	Description		Min	Nom	Max	Units
T_J	Junction temperature	Commercial	0	25	85	°C
		Industrial	–40	25	100	°C
V_{CCINT}	Internal supply voltage		1.140	1.200	1.260	V
V_{CCO}(1)	Output driver supply voltage		1.140	–	3.465	V
V_{CCAUX}	Auxiliary supply voltage		2.375	2.500	2.625	V
ΔV_{CCAUX}(2)	Voltage variance on VCCAUX when using a DCM		–	–	10	mV/ms
V_{IN}(3)	Voltage applied to all User I/O pins and Dual-Purpose pins relative to GND(4)(6)	V_{CCO} = 3.3V, IO	–0.3	–	3.75	V
		V_{CCO} = 3.3V, IO_Lxxy(7)	–0.3	–	3.75	V
		$V_{CCO} \le$ 2.5V, IO	–0.3	–	V_{CCO} + 0.3(4)	V
		$V_{CCO} \le$ 2.5V, IO_Lxxy(7)	–0.3	–	V_{CCO} + 0.3(4)	V
	Voltage applied to all Dedicated pins relative to GND(5)		–0.3	–	V_{CCAUX} + 0.3(5)	V

Notes:

1. The V_{CCO} range given here spans the lowest and highest operating voltages of all supported I/O standards. The recommended V_{CCO} range specific to each of the single-ended I/O standards is given in Table 35, and that specific to the differential standards is given in Table 37.
2. Only during DCM operation is it recommended that the rate of change of V_{CCAUX} not exceed 10 mV/ms.
3. Input voltages outside the recommended range are permissible provided that the I_{IK} input diode clamp diode rating is met. Refer to Table 28.
4. Each of the User I/O and Dual-Purpose pins is associated with one of the V_{CCO} rails. Meeting the V_{IN} limit ensures that the internal diode junctions that exist between these pins and their associated V_{CCO} and GND rails do not turn on. The absolute maximum rating is provided in Table 28.
5. All Dedicated pins (PROG_B, DONE, TCK, TDI, TDO, and TMS) draw power from the V_{CCAUX} rail (2.5V). Meeting the V_{IN} max limit ensures that the internal diode junctions that exist between each of these pins and the V_{CCAUX} and GND rails do not turn on.
6. See XAPP459, *Eliminating I/O Coupling Effects when Interfacing Large-Swing Single-Ended Signals to User I/O Pins on Spartan-3 Generation FPGAs*.
7. For single-ended signals that are placed on a differential-capable I/O, V_{IN} of –0.2V to –0.3V is supported but can cause increased leakage between the two pins. See the *Parasitic Leakage* section in UG331, *Spartan-3 Generation FPGA User Guide*.

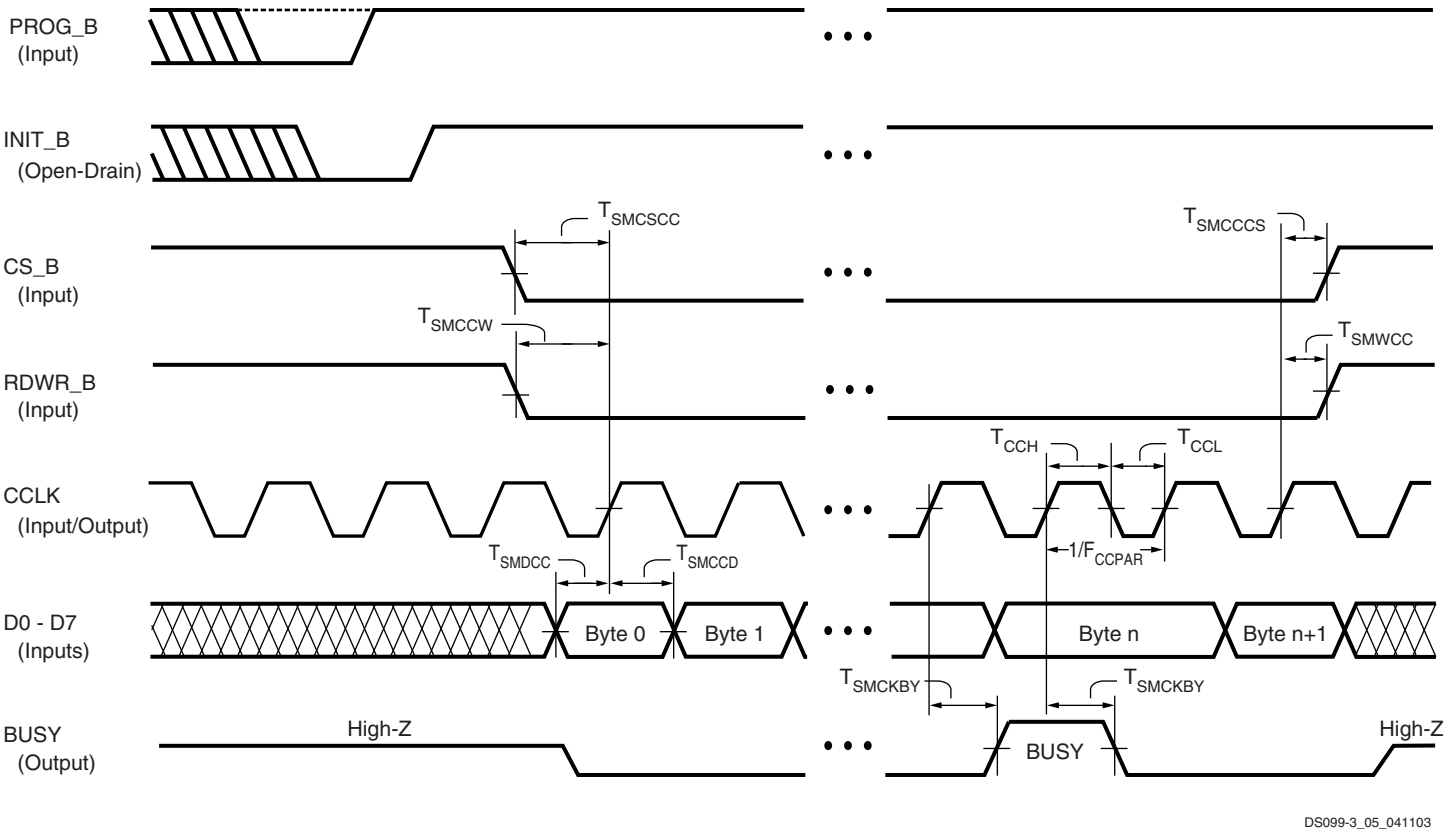


Figure 38: **Waveforms for Master and Slave Parallel Configuration**

Table 67: **Timing for the Master and Slave Parallel Configuration Modes**

Symbol	Description	Slave/ Master	All Speed Grades		Units
			Min	Max	
Clock-to-Output Times					
T_{SMCKBY}	The time from the rising transition on the CCLK pin to a signal transition at the BUSY pin	Slave	–	12.0	ns
Setup Times					
T_{SMDCC}	The time from the setup of data at the D0-D7 pins to the rising transition at the CCLK pin	Both	10.0	–	ns
T_{SMCSCC}	The time from the setup of a logic level at the CS_B pin to the rising transition at the CCLK pin		10.0	–	ns
T_{SMCCW}(3)	The time from the setup of a logic level at the RDWR_B pin to the rising transition at the CCLK pin		10.0	–	ns
Hold Times					
T_{SMCCD}	The time from the rising transition at the CCLK pin to the point when data is last held at the D0-D7 pins	Both	0	–	ns
T_{SMCCCS}	The time from the rising transition at the CCLK pin to the point when a logic level is last held at the CS_B pin		0	–	ns
T_{SMWCC}(3)	The time from the rising transition at the CCLK pin to the point when a logic level is last held at the RDWR_B pin		0	–	ns

Revision History

Date	Version	Description
04/11/03	1.0	Initial Xilinx release.
07/11/03	1.1	Extended Absolute Maximum Rating for junction temperature in Table 28. Added numbers for typical quiescent supply current (Table 34) and DLL timing.
02/06/04	1.2	Revised V_{IN} maximum rating (Table 28). Added power-on requirements (Table 30), leakage current number (Table 33), and differential output voltage levels (Table 38) for Rev. 0. Published new quiescent current numbers (Table 34). Updated pull-up and pull-down resistor strengths (Table 33). Added LVDCI_DV2 and LVPECL standards (Table 37 and Table 38). Changed CCLK setup time (Table 66 and Table 67).
03/04/04	1.3	Added timing numbers from v1.29 speed files as well as DCM timing (Table 58 through Table 63).
08/24/04	1.4	Added reference to errata documents on page 49. Clarified Absolute Maximum Ratings and added ESD information (Table 28). Explained V_{CCO} ramp time measurement (Table 30). Clarified I_L specification (Table 33). Updated quiescent current numbers and added information on power-on and surplus current (Table 34). Adjusted V_{REF} range for HSTL_III and HSTL_I_18 and changed V_{IH} min for LVCMOS12 (Table 35). Added note limiting V_{TT} range for SSTL2_II signal standards (Table 36). Calculated V_{OH} and V_{OL} levels for differential standards (Table 38). Updated Switching Characteristics with speed file v1.32 (Table 40 through Table 48 and Table 51 through Table 56). Corrected IOB test conditions (Table 41). Updated DCM timing with latest characterization data (Table 58 through Table 62). Improved DCM CLKIN pulse width specification (Table 58). Recommended use of Virtex-II FPGA Jitter calculator (Table 61). Improved DCM PSCLK pulse width specification (Table 62). Changed Phase Shifter lock time parameter (Table 63). Because the BitGen option Centered_x#_y# is not necessary for Variable Phase Shift mode, removed BitGen command table and referring text. Adjusted maximum CCLK frequency for the slave serial and parallel configuration modes (Table 66). Inverted CCLK waveform (Figure 37). Adjusted JTAG setup times (Table 68).
12/17/04	1.5	Updated timing parameters to match v1.35 speed file. Improved V_{CCO} ramp time specification (Table 30). Added a note limiting the rate of change of V_{CCAUX} (Table 32). Added typical quiescent current values for the XC3S2000, XC3S4000, and XC3S5000 (Table 34). Increased I_{OH} and I_{OL} for SSTL2-I and SSTL2-II standards (Table 36). Added SSO guidelines for the VQ, TQ, and PQ packages as well as edited SSO guidelines for the FT and FG packages (Table 50). Added maximum CCLK frequencies for configuration using compressed bitstreams (Table 66 and Table 67). Added specifications for the HSLVDCI standards (Table 35, Table 36, Table 44, Table 47, Table 48, and Table 50).
08/19/05	1.6	Updated timing parameters to match v1.37 speed file. All Spartan-3 FPGA part types, except XC3S5000, promoted to Production status. Removed V_{CCO} ramp rate restriction from all mask revision 'E' and later devices (Table 30). Added equivalent resistance values for internal pull-up and pull-down resistors (Table 33). Added worst-case quiescent current values for XC3S2000, XC3S4000, XC3S5000 (Table 34). Added industrial temperature range specification and improved typical quiescent current values (Table 34). Improved the DLL minimum clock input frequency specification from 24 MHz down to 18 MHz (Table 58). Improved the DFS minimum and maximum clock output frequency specifications (Table 60, Table 61). Added new miscellaneous DCM specifications (Table 64), primarily affecting Industrial temperature range applications. Updated Simultaneously Switching Output Guidelines and Table 50 for QFP packages. Added information on SSTL18_II I/O standard and timing to support DDR2 SDRAM interfaces. Added differential (or complementary single-ended) DIFF_HSTL_II_18 and DIFF_SSTL2_II I/O standards, including DCI terminated versions. Added electro-static discharge (ESD) data for the XC3S2000 and larger FPGAs (Table 28). Added link to Spartan-3 FPGA errata notices and how to receive automatic notifications of data sheet or errata changes.
04/03/06	2.0	Upgraded Module 3, removing Preliminary status. Moved XC3S5000 to Production status in Table 39. Finalized I/O timing on XC3S5000 for v1.38 speed files. Added minimum timing values for various logic and I/O paths. Corrected labels for R_{PU} and R_{PD} and updated R_{PD} conditions for in Table 33. Added final mask revision 'E' specifications for LVDS_25, RSDS_25, LVDSEXT_25 differential outputs to Table 38. Added BLVDS termination requirements to Figure 34. Improved recommended Simultaneous Switching Outputs (SSOs) limits in Table 50 for quad-flat packaged based on silicon testing using devices soldered on a printed circuit board. Updated Note 2 in Table 63. Updated Note 6 in Table 30. Added INIT_B minimum pulse width specification, T_{INIT}, to Table 65.
04/26/06	2.1	Updated document links.

HSWAP_EN: Disable Pull-up Resistors During Configuration

As shown in Table 76, a Low on this asynchronous pin enables pull-up resistors on all user I/Os not actively involved in the configuration process, although only until device configuration completes. A High disables the pull-up resistors during configuration, which is the desired state for some applications.

The dedicated configuration CONFIG pins (CCLK, DONE, PROG_B, HSWAP_EN, M2, M1, M0), the JTAG pins (TDI, TMS, TCK, TDO) and the INIT_B always have active pull-up resistors during configuration, regardless of the value on HSWAP_EN.

After configuration, HSWAP_EN becomes a "don't care" input and any pull-up resistors previously enabled by HSWAP_EN are disabled. If a user I/O in the application requires a pull-up resistor after configuration, place a PULLUP primitive on the associated I/O pin or, for some pins, set the associated bitstream generator option.

Table 76: **HSWAP_EN Encoding**

HSWAP_EN	Function
During Configuration	
0	Enable pull-up resistors on all pins not actively involved in the configuration process. Pull-ups are only active until configuration completes. See Table 79.
1	No pull-up resistors during configuration.
After Configuration, User Mode	
X	This pin has no function except during device configuration.

Notes:

1. X = don't care, either 0 or 1.

The Bitstream generator option HswapenPin determines whether a pull-up resistor to VCCAUX, a pull-down resistor, or no resistor is present on HSWAP_EN after configuration.

JTAG: Dedicated JTAG Port Pins

Table 77: **JTAG Pin Descriptions**

Pin Name	Direction	Description	Bitstream Generation Option
TCK	Input	**Test Clock:** The TCK clock signal synchronizes all boundary scan operations on its rising edge.	The BitGen option **TckPin** determines whether a pull-up resistor, pull-down resistor or no resistor is present.
TDI	Input	**Test Data Input:** TDI is the serial data input for all JTAG instruction and data registers. This input is sampled on the rising edge of TCK.	The BitGen option **TdiPin** determines whether a pull-up resistor, pull-down resistor or no resistor is present.
TMS	Input	**Test Mode Select:** The TMS input controls the sequence of states through which the JTAG TAP state machine passes. This input is sampled on the rising edge of TCK.	The BitGen option **TmsPin** determines whether a pull-up resistor, pull-down resistor or no resistor is present.
TDO	Output	**Test Data Output:** The TDO pin is the data output for all JTAG instruction and data registers. This output is sampled on the rising edge of TCK. The TDO output is an active totem-pole driver and is not like the open-collector TDO output on Virtex®-II Pro FPGAs.	The BitGen option **TdoPin** determines whether a pull-up resistor, pull-down resistor or no resistor is present.

These pins are dedicated connections to the four-wire IEEE 1532/IEEE 1149.1 JTAG port, shown in Figure 43 and described in Table 77. The JTAG port is used for boundary-scan testing, device configuration, application debugging, and possibly an additional serial port for the application. These pins are dedicated and are not available as user-I/O pins. Every package has four dedicated JTAG pins and these pins are powered by the +2.5V VCCAUX supply.

For additional information on JTAG configuration, see Boundary-Scan (JTAG) Mode, page 50.

Table 91: **TQ144 Package Pinout *(Cont'd)***

Bank	XC3S50, XC3S200, XC3S400 Pin Name	TQ144 Pin Number	Type
5	IO_L32P_5/GCLK2	P52	GCLK
6	IO_L01N_6/VRP_6	P36	DCI
6	IO_L01P_6/VRN_6	P35	DCI
6	IO_L20N_6	P33	I/O
6	IO_L20P_6	P32	I/O
6	IO_L21N_6	P31	I/O
6	IO_L21P_6	P30	I/O
6	IO_L22N_6	P28	I/O
6	IO_L22P_6	P27	I/O
6	IO_L23N_6	P26	I/O
6	IO_L23P_6	P25	I/O
6	IO_L24N_6/VREF_6	P24	VREF
6	IO_L24P_6	P23	I/O
6	IO_L40N_6	P21	I/O
6	IO_L40P_6/VREF_6	P20	VREF
7	IO/VREF_7	P4	VREF
7	IO_L01N_7/VRP_7	P2	DCI
7	IO_L01P_7/VRN_7	P1	DCI
7	IO_L20N_7	P6	I/O
7	IO_L20P_7	P5	I/O
7	IO_L21N_7	P8	I/O
7	IO_L21P_7	P7	I/O
7	IO_L22N_7	P11	I/O
7	IO_L22P_7	P10	I/O
7	IO_L23N_7	P13	I/O
7	IO_L23P_7	P12	I/O
7	IO_L24N_7	P15	I/O
7	IO_L24P_7	P14	I/O
7	IO_L40N_7/VREF_7	P18	VREF
7	IO_L40P_7	P17	I/O
0,1	VCCO_TOP	P126	VCCO
0,1	VCCO_TOP	P138	VCCO
0,1	VCCO_TOP	P115	VCCO
2,3	VCCO_RIGHT	P106	VCCO
2,3	VCCO_RIGHT	P75	VCCO
2,3	VCCO_RIGHT	P91	VCCO
4,5	VCCO_BOTTOM	P54	VCCO
4,5	VCCO_BOTTOM	P43	VCCO
4,5	VCCO_BOTTOM	P66	VCCO
6,7	VCCO_LEFT	P19	VCCO

TQ144 Footprint

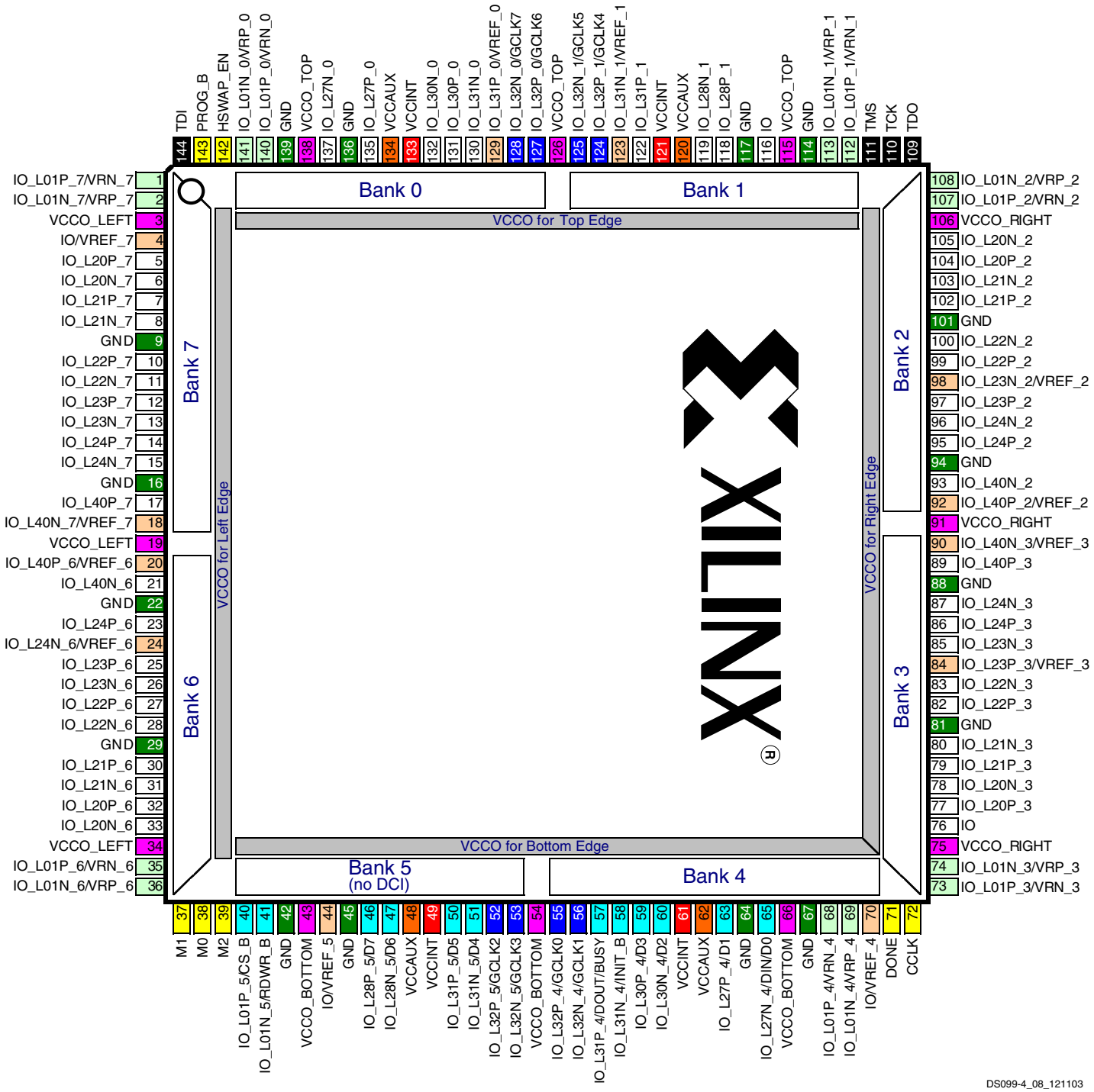


Figure 46: **TQ144 Package Footprint (Top View). Note pin 1 indicator in top-left corner and logo orientation.**

51 **I/O:** Unrestricted, general-purpose user I/O	12 **DUAL:** Configuration pin, then possible user I/O	12 **VREF:** User I/O or input voltage reference for bank
14 **DCI:** User I/O or reference resistor input for bank	8 **GCLK:** User I/O or global clock buffer input	12 **VCCO:** Output voltage supply for bank
7 **CONFIG:** Dedicated configuration pins	4 **JTAG:** Dedicated JTAG port pins	4 **VCCINT:** Internal core voltage supply (+1.2V)
0 **N.C.:** No unconnected pins in this package	16 **GND:** Ground	4 **VCCAUX:** Auxiliary voltage supply (+2.5V)

Table 96: **FT256 Package Pinout *(Cont'd)***

Bank	XC3S200, XC3S400, XC3S1000 Pin Name	FT256 Pin Number	Type
7	IO_L24P_7	G4	I/O
7	IO_L39N_7	H3	I/O
7	IO_L39P_7	H4	I/O
7	IO_L40N_7/VREF_7	H1	VREF
7	IO_L40P_7	G1	I/O
7	VCCO_7	G6	VCCO
7	VCCO_7	H5	VCCO
7	VCCO_7	H6	VCCO
N/A	GND	A1	GND
N/A	GND	A16	GND
N/A	GND	B2	GND
N/A	GND	B9	GND
N/A	GND	B15	GND
N/A	GND	F6	GND
N/A	GND	F11	GND
N/A	GND	G7	GND
N/A	GND	G8	GND
N/A	GND	G9	GND
N/A	GND	G10	GND
N/A	GND	H2	GND
N/A	GND	H7	GND
N/A	GND	H8	GND
N/A	GND	H9	GND
N/A	GND	H10	GND
N/A	GND	J7	GND
N/A	GND	J8	GND
N/A	GND	J9	GND
N/A	GND	J10	GND
N/A	GND	J15	GND
N/A	GND	K7	GND
N/A	GND	K8	GND
N/A	GND	K9	GND
N/A	GND	K10	GND
N/A	GND	L6	GND
N/A	GND	L11	GND
N/A	GND	R2	GND
N/A	GND	R8	GND
N/A	GND	R15	GND
N/A	GND	T1	GND

User I/Os by Bank

Table 101 indicates how the available user-I/O pins are distributed between the eight I/O banks for the XC3S400 in the FG456 package. Similarly, Table 102 shows how the available user-I/O pins are distributed between the eight I/O banks for the XC3S1000, XC3S1500, and XC3S2000 in the FG456 package.

Table 101: **User I/Os Per Bank for XC3S400 in FG456 Package**

Edge	I/O Bank	Maximum I/O	All Possible I/O Pins by Type				
			I/O	DUAL	DCI	VREF	GCLK
Top	0	35	27	0	2	4	2
	1	35	27	0	2	4	2
Right	2	31	25	0	2	4	0
	3	31	25	0	2	4	0
Bottom	4	35	21	6	2	4	2
	5	35	21	6	2	4	2
Left	6	31	25	0	2	4	0
	7	31	25	0	2	4	0

Table 102: **User I/Os Per Bank for XC3S1000, XC3S1500, and XC3S2000 in FG456 Package**

Edge	I/O Bank	Maximum I/O	All Possible I/O Pins by Type				
			I/O	DUAL	DCI	VREF	GCLK
Top	0	40	31	0	2	5	2
	1	40	31	0	2	5	2
Right	2	43	37	0	2	4	0
	3	43	37	0	2	4	0
Bottom	4	41	26	6	2	5	2
	5	40	25	6	2	5	2
Left	6	43	37	0	2	4	0
	7	43	37	0	2	4	0

Table 103: **FG676 Package Pinout *(Cont'd)***

Bank	XC3S1000 Pin Name	XC3S1500 Pin Name	XC3S2000 Pin Name	XC3S4000 Pin Name	XC3S5000 Pin Name	FG676 Pin Number	Type
2	N.C. (◆)	IO_L06N_2	IO_L06N_2	IO_L06N_2	IO_L06N_2	G20	I/O
2	N.C. (◆)	IO_L06P_2	IO_L06P_2	IO_L06P_2	IO_L06P_2	G21	I/O
2	N.C. (◆)	IO_L07N_2	IO_L07N_2	IO_L07N_2	IO_L07N_2	F23	I/O
2	N.C. (◆)	IO_L07P_2	IO_L07P_2	IO_L07P_2	IO_L07P_2	F24	I/O
2	N.C. (◆)	IO_L08N_2	IO_L08N_2	IO_L08N_2	IO_L08N_2	G22	I/O
2	N.C. (◆)	IO_L08P_2	IO_L08P_2	IO_L08P_2	IO_L08P_2	G23	I/O
2	N.C. (◆)	IO_L09N_2/VREF_2(1)	IO_L09N_2/VREF_2	IO_L09N_2/VREF_2	IO_L09N_2/VREF_2	F25	VREF(1)
2	N.C. (◆)	IO_L09P_2	IO_L09P_2	IO_L09P_2	IO_L09P_2	F26	I/O
2	N.C. (◆)	IO_L10N_2	IO_L10N_2	IO_L10N_2	IO_L10N_2	G25	I/O
2	N.C. (◆)	IO_L10P_2	IO_L10P_2	IO_L10P_2	IO_L10P_2	G26	I/O
2	IO_L14N_2	IO_L14N_2	IO_L14N_2(2)	IO_L11N_2(2)	IO_L11N_2	H20	I/O
2	IO_L14P_2	IO_L14P_2	IO_L14P_2(2)	IO_L11P_2(2)	IO_L11P_2	H21	I/O
2	IO_L16N_2	IO_L16N_2	IO_L16N_2(2)	IO_L12N_2(2)	IO_L12N_2	H22	I/O
2	IO_L16P_2	IO_L16P_2	IO_L16P_2(2)	IO_L12P_2(2)	IO_L12P_2	J21	I/O
2	IO_L17N_2	IO_L17N_2	IO_L17N_2(2)	IO_L13N_2(2)	IO(3)	H23	I/O
2	IO_L17P_2/VREF_2	IO_L17P_2/VREF_2	IO_L17P_2(2)/VREF_2	IO_L13P_2(2)/VREF_2	IO/VREF_2(3)	H24	VREF
2	IO_L19N_2	IO_L19N_2	IO_L19N_2	IO_L19N_2	IO_L19N_2	H25	I/O
2	IO_L19P_2	IO_L19P_2	IO_L19P_2	IO_L19P_2	IO_L19P_2	H26	I/O
2	IO_L20N_2	IO_L20N_2	IO_L20N_2	IO_L20N_2	IO_L20N_2	J20	I/O
2	IO_L20P_2	IO_L20P_2	IO_L20P_2	IO_L20P_2	IO_L20P_2	K20	I/O
2	IO_L21N_2	IO_L21N_2	IO_L21N_2	IO_L21N_2	IO_L21N_2	J22	I/O
2	IO_L21P_2	IO_L21P_2	IO_L21P_2	IO_L21P_2	IO_L21P_2	J23	I/O
2	IO_L22N_2	IO_L22N_2	IO_L22N_2	IO_L22N_2	IO_L22N_2	J24	I/O
2	IO_L22P_2	IO_L22P_2	IO_L22P_2	IO_L22P_2	IO_L22P_2	J25	I/O
2	IO_L23N_2/VREF_2	IO_L23N_2/VREF_2	IO_L23N_2/VREF_2	IO_L23N_2/VREF_2	IO_L23N_2/VREF_2	K21	VREF
2	IO_L23P_2	IO_L23P_2	IO_L23P_2	IO_L23P_2	IO_L23P_2	K22	I/O
2	IO_L24N_2	IO_L24N_2	IO_L24N_2	IO_L24N_2	IO_L24N_2	K23	I/O
2	IO_L24P_2	IO_L24P_2	IO_L24P_2	IO_L24P_2	IO_L24P_2	K24	I/O
2	IO_L26N_2	IO_L26N_2	IO_L26N_2	IO_L26N_2	IO_L26N_2	K25	I/O
2	IO_L26P_2	IO_L26P_2	IO_L26P_2	IO_L26P_2	IO_L26P_2	K26	I/O
2	IO_L27N_2	IO_L27N_2	IO_L27N_2	IO_L27N_2	IO_L27N_2	L19	I/O
2	IO_L27P_2	IO_L27P_2	IO_L27P_2	IO_L27P_2	IO_L27P_2	L20	I/O
2	IO_L28N_2	IO_L28N_2	IO_L28N_2	IO_L28N_2	IO_L28N_2	L21	I/O
2	IO_L28P_2	IO_L28P_2	IO_L28P_2	IO_L28P_2	IO_L28P_2	L22	I/O
2	IO_L29N_2	IO_L29N_2	IO_L29N_2	IO_L29N_2	IO_L29N_2	L25	I/O
2	IO_L29P_2	IO_L29P_2	IO_L29P_2	IO_L29P_2	IO_L29P_2	L26	I/O
2	IO_L31N_2	IO_L31N_2	IO_L31N_2	IO_L31N_2	IO_L31N_2	M19	I/O
2	IO_L31P_2	IO_L31P_2	IO_L31P_2	IO_L31P_2	IO_L31P_2	M20	I/O
2	IO_L32N_2	IO_L32N_2	IO_L32N_2	IO_L32N_2	IO_L32N_2	M21	I/O
2	IO_L32P_2	IO_L32P_2	IO_L32P_2	IO_L32P_2	IO_L32P_2	M22	I/O
2	IO_L33N_2	IO_L33N_2	IO_L33N_2	IO_L33N_2	IO_L33N_2	L23	I/O
2	IO_L33P_2	IO_L33P_2	IO_L33P_2	IO_L33P_2	IO_L33P_2	M24	I/O

Table 107: **FG900 Package Pinout *(Cont'd)***

Bank	XC3S2000 Pin Name	XC3S4000, XC3S5000 Pin Name	FG900 Pin Number	Type
4	IO_L11P_4	IO_L11P_4	AE21	I/O
4	IO_L12N_4	IO_L12N_4	AH21	I/O
4	IO_L12P_4	IO_L12P_4	AJ21	I/O
4	IO_L13N_4	IO_L13N_4	AB21	I/O
4	IO_L13P_4	IO_L13P_4	AA20	I/O
4	IO_L14N_4	IO_L14N_4	AC20	I/O
4	IO_L14P_4	IO_L14P_4	AD20	I/O
4	IO_L15N_4	IO_L15N_4	AE20	I/O
4	IO_L15P_4	IO_L15P_4	AF20	I/O
4	IO_L16N_4	IO_L16N_4	AG20	I/O
4	IO_L16P_4	IO_L16P_4	AH20	I/O
4	IO_L17N_4	IO_L17N_4	AJ20	I/O
4	IO_L17P_4	IO_L17P_4	AK20	I/O
4	IO_L18N_4	IO_L18N_4	AA19	I/O
4	IO_L18P_4	IO_L18P_4	AB19	I/O
4	IO_L19N_4	IO_L19N_4	AC19	I/O
4	IO_L19P_4	IO_L19P_4	AD19	I/O
4	IO_L20N_4	IO_L20N_4	AE19	I/O
4	IO_L20P_4	IO_L20P_4	AF19	I/O
4	IO_L21N_4	IO_L21N_4	AG19	I/O
4	IO_L21P_4	IO_L21P_4	AH19	I/O
4	IO_L22N_4/VREF_4	IO_L22N_4/VREF_4	AJ19	VREF
4	IO_L22P_4	IO_L22P_4	AK19	I/O
4	IO_L23N_4	IO_L23N_4	AB18	I/O
4	IO_L23P_4	IO_L23P_4	AC18	I/O
4	IO_L24N_4	IO_L24N_4	AE18	I/O
4	IO_L24P_4	IO_L24P_4	AF18	I/O
4	IO_L25N_4	IO_L25N_4	AJ18	I/O
4	IO_L25P_4	IO_L25P_4	AK18	I/O
4	IO_L26N_4	IO_L26N_4	AA17	I/O
4	IO_L26P_4/VREF_4	IO_L26P_4/VREF_4	AB17	VREF
4	IO_L27N_4/DIN/D0	IO_L27N_4/DIN/D0	AD17	DUAL
4	IO_L27P_4/D1	IO_L27P_4/D1	AE17	DUAL
4	IO_L28N_4	IO_L28N_4	AH17	I/O
4	IO_L28P_4	IO_L28P_4	AJ17	I/O
4	IO_L29N_4	IO_L29N_4	AB16	I/O
4	IO_L29P_4	IO_L29P_4	AC16	I/O
4	IO_L30N_4/D2	IO_L30N_4/D2	AD16	DUAL
4	IO_L30P_4/D3	IO_L30P_4/D3	AE16	DUAL
4	IO_L31N_4/INIT_B	IO_L31N_4/INIT_B	AG16	DUAL

Table 107: **FG900 Package Pinout *(Cont'd)***

Bank	XC3S2000 Pin Name	XC3S4000, XC3S5000 Pin Name	FG900 Pin Number	Type
N/A	GND	GND	R17	GND
N/A	GND	GND	T17	GND
N/A	GND	GND	U17	GND
N/A	GND	GND	V17	GND
N/A	GND	GND	AC17	GND
N/A	GND	GND	AF17	GND
N/A	GND	GND	AK17	GND
N/A	GND	GND	N18	GND
N/A	GND	GND	P18	GND
N/A	GND	GND	R18	GND
N/A	GND	GND	T18	GND
N/A	GND	GND	U18	GND
N/A	GND	GND	V18	GND
N/A	GND	GND	R19	GND
N/A	GND	GND	T19	GND
N/A	GND	GND	A21	GND
N/A	GND	GND	E21	GND
N/A	GND	GND	H21	GND
N/A	GND	GND	AC21	GND
N/A	GND	GND	AF21	GND
N/A	GND	GND	AK21	GND
N/A	GND	GND	K23	GND
N/A	GND	GND	P23	GND
N/A	GND	GND	U23	GND
N/A	GND	GND	AA23	GND
N/A	GND	GND	A25	GND
N/A	GND	GND	AK25	GND
N/A	GND	GND	E26	GND
N/A	GND	GND	K26	GND
N/A	GND	GND	P26	GND
N/A	GND	GND	U26	GND
N/A	GND	GND	AA26	GND
N/A	GND	GND	AF26	GND
N/A	GND	GND	A29	GND
N/A	GND	GND	B29	GND
N/A	GND	GND	AJ29	GND
N/A	GND	GND	AK29	GND
N/A	GND	GND	A30	GND
N/A	GND	GND	B30	GND
N/A	GND	GND	F30	GND

Table 110: **FG1156 Package Pinout *(Cont'd)***

Bank	XC3S4000 Pin Name	XC3S5000 Pin Name	FG1156 Pin Number	Type
7	IO_L01P_7/VRN_7	IO_L01P_7/VRN_7	C2	DCI
7	IO_L02N_7	IO_L02N_7	D1	I/O
7	IO_L02P_7	IO_L02P_7	D2	I/O
7	IO_L03N_7/VREF_7	IO_L03N_7/VREF_7	E2	VREF
7	IO_L03P_7	IO_L03P_7	E3	I/O
7	IO_L04N_7	IO_L04N_7	F3	I/O
7	IO_L04P_7	IO_L04P_7	F4	I/O
7	IO_L05N_7	IO_L05N_7	F1	I/O
7	IO_L05P_7	IO_L05P_7	F2	I/O
7	IO_L06N_7	IO_L06N_7	G5	I/O
7	IO_L06P_7	IO_L06P_7	G6	I/O
7	IO_L07N_7	IO_L07N_7	H5	I/O
7	IO_L07P_7	IO_L07P_7	H6	I/O
7	IO_L08N_7	IO_L08N_7	H1	I/O
7	IO_L08P_7	IO_L08P_7	H2	I/O
7	IO_L09N_7	IO_L09N_7	J6	I/O
7	IO_L09P_7	IO_L09P_7	J7	I/O
7	IO_L10N_7	IO_L10N_7	J4	I/O
7	IO_L10P_7/VREF_7	IO_L10P_7/VREF_7	H4	VREF
7	IO_L11N_7	IO_L11N_7	J2	I/O
7	IO_L11P_7	IO_L11P_7	J3	I/O
7	IO_L12N_7	IO_L12N_7	K9	I/O
7	IO_L12P_7	IO_L12P_7	J8	I/O
7	IO_L13N_7	IO_L13N_7	K7	I/O
7	IO_L13P_7	IO_L13P_7	K8	I/O
7	IO_L14N_7	IO_L14N_7	K5	I/O
7	IO_L14P_7	IO_L14P_7	K6	I/O
7	IO_L15N_7	IO_L15N_7	K3	I/O
7	IO_L15P_7	IO_L15P_7	K4	I/O
7	IO_L16N_7	IO_L16N_7	K1	I/O
7	IO_L16P_7/VREF_7	IO_L16P_7/VREF_7	K2	VREF
7	IO_L17N_7	IO_L17N_7	L9	I/O
7	IO_L17P_7	IO_L17P_7	L10	I/O
7	IO_L19N_7/VREF_7	IO_L19N_7/VREF_7	L1	VREF
7	IO_L19P_7	IO_L19P_7	L2	I/O
7	IO_L20N_7	IO_L20N_7	M10	I/O
7	IO_L20P_7	IO_L20P_7	M11	I/O
7	IO_L21N_7	IO_L21N_7	M7	I/O
7	IO_L21P_7	IO_L21P_7	M8	I/O
7	IO_L22N_7	IO_L22N_7	M5	I/O

Table 110: **FG1156 Package Pinout *(Cont'd)***

Bank	XC3S4000 Pin Name	XC3S5000 Pin Name	FG1156 Pin Number	Type
7	IO_L22P_7	IO_L22P_7	M6	I/O
7	IO_L23N_7	IO_L23N_7	M3	I/O
7	IO_L23P_7	IO_L23P_7	M4	I/O
7	IO_L24N_7	IO_L24N_7	N10	I/O
7	IO_L24P_7	IO_L24P_7	M9	I/O
7	IO_L25N_7	IO_L25N_7	N3	I/O
7	IO_L25P_7	IO_L25P_7	N4	I/O
7	IO_L26N_7	IO_L26N_7	P11	I/O
7	IO_L26P_7	IO_L26P_7	N11	I/O
7	IO_L27N_7	IO_L27N_7	P7	I/O
7	IO_L27P_7/VREF_7	IO_L27P_7/VREF_7	P8	VREF
7	IO_L28N_7	IO_L28N_7	P5	I/O
7	IO_L28P_7	IO_L28P_7	P6	I/O
7	IO_L29N_7	IO_L29N_7	P3	I/O
7	IO_L29P_7	IO_L29P_7	P4	I/O
7	IO_L30N_7	IO_L30N_7	R6	I/O
7	IO_L30P_7	IO_L30P_7	R7	I/O
7	IO_L31N_7	IO_L31N_7	R3	I/O
7	IO_L31P_7	IO_L31P_7	R4	I/O
7	IO_L32N_7	IO_L32N_7	R1	I/O
7	IO_L32P_7	IO_L32P_7	R2	I/O
7	IO_L33N_7	IO_L33N_7	T10	I/O
7	IO_L33P_7	IO_L33P_7	R9	I/O
7	IO_L34N_7	IO_L34N_7	T6	I/O
7	IO_L34P_7	IO_L34P_7	T7	I/O
7	IO_L35N_7	IO_L35N_7	T2	I/O
7	IO_L35P_7	IO_L35P_7	T3	I/O
7	IO_L37N_7	IO_L37N_7	U7	I/O
7	IO_L37P_7/VREF_7	IO_L37P_7/VREF_7	U8	VREF
7	IO_L38N_7	IO_L38N_7	U5	I/O
7	IO_L38P_7	IO_L38P_7	U6	I/O
7	IO_L39N_7	IO_L39N_7	U3	I/O
7	IO_L39P_7	IO_L39P_7	U4	I/O
7	IO_L40N_7/VREF_7	IO_L40N_7/VREF_7	U1	VREF
7	IO_L40P_7	IO_L40P_7	U2	I/O
7	N.C. (◆)	IO_L41N_7	G3	I/O
7	N.C. (◆)	IO_L41P_7	G4	I/O
7	N.C. (◆)	IO_L44N_7	L6	I/O
7	N.C. (◆)	IO_L44P_7	L7	I/O
7	IO_L45N_7	IO_L45N_7	M1	I/O

All Devices

Top Right Corner of FG1156 Package (Top View)

12	**DUAL:** Configuration pin, then possible user I/O	16	**DCI:** User I/O or reference resistor input for bank	8	**GCLK:** User I/O or global clock buffer input
7	**CONFIG:** Dedicated configuration pins	4	**JTAG:** Dedicated JTAG port pins	104	**VCCO:** Output voltage supply for bank
40	**VCCINT:** Internal core voltage supply (+1.2V)	32	**VCCAUX:** Auxiliary voltage supply (+2.5V)	184	**GND:** Ground

Bank 1

18	19	20	21	22	23	24	25	26	27	28	29	30	31	32	33	34	
I/O	GND	I/O L40N_1	I/O L26N_1	GND	I/O L19N_1	I/O L15N_1	I/O L14N_1	GND	I/O L08N_1	I/O L34N_1 ◆	I/O L05N_1	GND	I/O L02N_1	I/O L01N_1 VRP_1	GND	GND	A
I/O L32N_1 GCLK5	I/O L28N_1	I/O L40P_1	I/O L26P_1	VCCO_1	I/O L19P_1	I/O L15P_1	I/O L14P_1	I/O	I/O L08P_1	I/O L34P_1 ◆	I/O L05P_1	I/O L03N_1	I/O L02P_1	I/O L01P_1 VRN_1	GND	GND	B
I/O L32P_1 GCLK4	I/O L28P_1	I/O L39N_1	I/O L25N_1	I/O L22N_1	I/O	GND	I/O L13N_1	I/O L10N_1 VREF_1	VCCO_1	I/O L33N_1 ◆	I/O L04N_1	I/O L03P_1	VCCO_1	GND	I/O L01N_2 VRP_2	I/O L01P_2 VRN_2	C
I/O L31N_1 VREF_1	VCCO_1	I/O L39P_1	I/O L25P_1	I/O L22P_1	I/O L18N_1	VCCO_1	I/O L13P_1	I/O L10P_1	I/O L07N_1	I/O L33P_1 ◆	I/O L04P_1	IO VREF_1	TCK	VCCO_2	I/O L02N_2	I/O L02P_2	D
I/O L31P_1	GND	VCCAUX	I/O	GND	I/O L18P_1	VCCAUX	I/O	GND	I/O L07P_1	I/O L06N_1 VREF_1	VCCAUX	GND	TDO	I/O L03N_2 VREF_2	I/O L03P_2	GND	E
I/O	I/O L27N_1	I/O L38N_1	I/O L24N_1	VCCO_1	I/O L17N_1 VREF_1	I/O L36N_1 ◆	I/O L12N_1	I/O L09N_1	I/O	I/O L06P_1	I/O	VCCAUX	I/O L04N_2	I/O L04P_2	I/O L41N_2	I/O L41P_2	F
I/O L30N_1	I/O L27P_1	I/O L38P_1	I/O L24P_1	I/O L21N_1	I/O L17P_1	I/O L36P_1 ◆	I/O L12P_1	I/O L09P_1	VCCO_1	GND	I/O L05N_2	I/O L05P_2	I/O L42N_2 ◆	I/O L42P_2 ◆	I/O	I/O	G
I/O L30P_1	VCCAUX	VCCO_1	I/O L23N_1	I/O L21P_1	I/O	VCCO_1	I/O L11N_1	I/O	TMS	VCCO_2	I/O L06N_2	I/O L06P_2	I/O L09N_2 VREF_2	VCCO_2	I/O L07N_2	I/O L07P_2	H
I/O L29N_1	GND	I/O L37N_1	I/O L23P_1	GND	I/O L16N_1	I/O L35N_1 ◆	I/O L11P_1	I/O ◆	I/O L11N_2	I/O L08N_2	I/O L08P_2	GND	I/O L09P_2	I/O L10N_2	I/O L10P_2	GND	J
I/O L29P_1	I/O	I/O L37P_1	IO VREF_1	I/O L20N_1	I/O L16P_1	I/O L35P_1 ◆	GND	I/O L11P_2	I/O L12N_2	I/O L12P_2	I/O L13N_2	I/O L13P_2 VREF_2	I/O L14N_2	I/O L14P_2	I/O L15N_2	I/O L15P_2	K
IO VREF_1	I/O	I/O	I/O	I/O L20P_1	I/O ◆	I/O	I/O L16N_2	I/O L16P_2	VCCO_2	I/O L17N_2 ◆	I/O L17P_2 VREF_2 ◆	VCCAUX	VCCO_2	GND	I/O L45N_2	I/O L45P_2	L
VCCINT	VCCO_1	VCCO_1	VCCO_1	VCCO_1	VCCINT	I/O L46N_2	I/O L46P_2	I/O L21N_2	I/O L47N_2	I/O L47P_2	I/O L19N_2	I/O L19P_2	I/O L20N_2	I/O L20P_2	I/O L48N_2	I/O L48P_2	M
GND	VCCINT	VCCINT	VCCINT	VCCINT	VCCO_2	I/O L24N_2	I/O L21P_2	GND	I/O L22N_2	I/O L22P_2	VCCO_2	GND	I/O L23N_2 VREF_2	I/O L23P_2	VCCO_2	GND	N
GND	GND	GND	GND	VCCINT	VCCO_2	I/O L24P_2	I/O L49N_2 ◆	I/O L49P_2 ◆	I/O L50N_2	I/O L50P_2	I/O L26N_2	I/O L26P_2	I/O L27N_2	I/O L27P_2	I/O L28N_2	I/O L28P_2	P
GND	GND	GND	GND	VCCINT	VCCO_2	I/O L29N_2	I/O L29P_2	I/O L33N_2	VCCO_2	I/O L30N_2	I/O L30P_2	VCCAUX	I/O L31N_2	I/O L31P_2	I/O L32N_2	I/O L32P_2	R
GND	GND	GND	GND	VCCINT	VCCO_2	I/O L51N_2 ◆	I/O L33P_2	GND	VCCAUX	I/O L34N_2 VREF_2	I/O L34P_2	GND	VCCO_2	I/O L35N_2	I/O L35P_2	GND	T
GND	GND	GND	GND	GND	VCCINT	I/O L51P_2 ◆	I/O	I/O	I/O L37N_2	I/O L37P_2	I/O L38N_2	I/O L38P_2	I/O L39N_2	I/O L39P_2	I/O L40N_2	I/O L40P_2 VREF_2	U

Bank 2

DS099-4_14b_072903

Figure 58: FG1156 Package Footprint (Top View) Continued

18	19	20	21	22	23	24	25	26	27	28	29	30	31	32	33	34	
GND	GND	GND	GND	GND	VCCINT	I/O L51N_3 ◆	I/O	I/O	I/O L37P_3	I/O L37N_3	I/O L38P_3	I/O L38N_3	I/O L39P_3	I/O L39N_3	I/O L40P_3	I/O L40N_3 VREF_3	V
GND	GND	GND	GND	VCCINT	VCCO_3	I/O L51P_3 ◆	I/O L33N_3	GND	VCCAUX	I/O L34P_3 VREF_3	I/O L34N_3	GND	VCCO_3	I/O L35P_3	I/O L35N_3	GND	W
GND	GND	GND	GND	VCCINT	VCCO_3	I/O L50P_3	I/O L50N_3	I/O L33P_3	VCCO_3	I/O L30P_3	I/O L30N_3	VCCAUX	I/O L31P_3	I/O L31N_3	I/O L32P_3	I/O L32N_3	Y
GND	GND	GND	GND	VCCINT	VCCO_3	I/O L48N_3	I/O L49P_3 ◆	I/O L49N_3 ◆	I/O L26P_3	I/O L26N_3	I/O L27P_3	I/O L27N_3	I/O L28P_3	I/O L28N_3	I/O L29P_3	I/O L29N_3	AA
GND	VCCINT	VCCINT	VCCINT	VCCINT	VCCO_3	I/O L48P_3	I/O L24N_3	GND	I/O L46P_3	I/O L46N_3	VCCO_3	GND	I/O L47P_3	I/O L47N_3	VCCO_3	GND	AB
VCCINT	VCCO_4	VCCO_4	VCCO_4	VCCO_4	VCCINT	I/O L20P_3	I/O L20N_3	I/O L24P_3	I/O L21P_3	I/O L21N_3	I/O L22P_3	I/O L22N_3	I/O L23P_3 VREF_3	I/O L23N_3	I/O L45P_3	I/O L45N_3	AC
I/O	I/O	I/O	I/O L18N_4	I/O	I/O L11N_4	DONE	I/O L17P_3 VREF_3	I/O L17N_3	VCCO_3	I/O L44P_3 ◆	I/O L44N_3 ◆	VCCAUX	VCCO_3	GND	I/O L19P_3	I/O L19N_3	AD
I/O	I/O	I/O L23N_4	I/O L18P_4	I/O	I/O L11P_4	I/O ◆	GND	I/O L12N_3	I/O L13P_3	I/O L13N_3 VREF_3	I/O L14P_3	I/O L14N_3	I/O L15P_3	I/O L15N_3	I/O L16P_3	I/O L16N_3	AE
I/O L29N_4	GND	I/O L23P_4	IO VREF_4	GND	I/O L12N_4	I/O	I/O L07N_4	I/O ◆	I/O L12P_3	I/O L09P_3 VREF_3	I/O L09N_3	GND	I/O L10N_3	I/O L11P_3	I/O L11N_3	GND	AF
I/O L29P_4	VCCAUX	VCCO_4	I/O L19N_4	I/O L16N_4	I/O L12P_4	VCCO_4	I/O L07P_4	I/O	I/O	VCCO_3	I/O L07P_3	I/O L07N_3	I/O L10P_3	VCCO_3	I/O L08P_3	I/O L08N_3	AG
I/O L30N_4 D2	I/O L27N_4 DIN D0	I/O L24N_4	I/O L19P_4	I/O L16P_4	IO VREF_4	I/O L39N_4 ◆	I/O L08N_4	I/O L05N_4	VCCO_4	GND	I/O L06P_3	I/O L06N_3	I/O L41P_3 ◆	I/O L41N_3 ◆	I/O	I/O	AH
I/O L30P_4 D3	I/O L27P_4 D1	I/O L24P_4	I/O L20N_4	VCCO_4	I/O L13N_4	I/O L39P_4 ◆	I/O L08P_4	I/O L05P_4	I/O	I/O L35N_4	I/O	VCCAUX	I/O L04P_3	I/O L04N_3	I/O L05P_3	I/O L05N_3	AJ
IO VREF_4	GND	VCCAUX	I/O L20P_4	GND	I/O L13P_4	VCCAUX	I/O	GND	I/O L38N_4	I/O L35P_4	VCCAUX	GND	N.C. ◆ ■	I/O L03P_3	I/O L03N_3	GND	AK
I/O L31N_4 INIT_B	VCCO_4	I/O L25N_4	I/O L21N_4	I/O L17N_4	I/O L14N_4	VCCO_4	I/O L09N_4	I/O L06N_4 VREF_4	I/O L38P_4	I/O L36N_4 ◆	I/O L33N_4	IO VREF_4	CCLK	VCCO_3	I/O L02P_3	I/O L02N_3 VREF_3	AL
I/O L31P_4 DOUT BUSY	I/O L28N_4	I/O L25P_4	I/O L21P_4	I/O L17P_4	I/O L14P_4	GND	I/O L09P_4	I/O L06P_4	VCCO_4	I/O L36P_4 ◆	I/O L33P_4	I/O L03N_4	VCCO_4	GND	I/O L01P_3 VRN_3	I/O L01N_3 VRP_3	AM
I/O L32N_4 GCLK1	I/O L28P_4	I/O L26N_4	I/O L22N_4 VREF_4	VCCO_4	I/O L15N_4	I/O L40N_4 ◆	I/O L10N_4	I/O	I/O L04N_4	I/O L37N_4 ◆	I/O L34N_4	I/O L03P_4	I/O L02N_4	I/O L01N_4 VRP_4	GND	GND	AN
I/O L32P_4 GCLK0	GND	I/O L26P_4 VREF_4	I/O L22P_4	GND	I/O L15P_4	I/O L40P_4 ◆	I/O L10P_4	GND	I/O L04P_4	I/O L37P_4 ◆	I/O L34P_4	GND	I/O L02P_4	I/O L01P_4 VRN_4	GND	GND	AP

Bank 3

Bank 4

DS099-4_14d_072903

Bottom Right Corner of FG1156 Package (Top View)

Figure 60: FG1156 Package Footprint (Top View) Continued